Document Number: ITEH58007C6 Preliminary Datasheet V1.3

### 7W,C band 28V Plastic RF LDMOS Transistor

### **Description**

The ITEH58007C6 is a 7-watt, highly rugged, LDMOS transistor, designed for any general applications at frequencies 4.8 to 6GHz, in 10\*6mm QFN plastic package, supporting surface mounted on PCB through high density grounding vias.

• Typical 4.9-6.2GHz Class AB RF Performance (On Innogration fixture with device soldered).

### $V_{DS} = 28V$ . $I_{DQ} = 65mA$

<b>V</b> DS <b>– 20V</b> , <b>I</b> DQ	- 63IIIA						
Freq	P1dB	P1dB	P1dB	P1dB	P3dB	P3dB	P3dB
$(\mathrm{MHz})$	(dBm)	(W)	Eff(%)	Gain(dB)	(dBm)	(W)	Eff(%)
4900	38. 71	7.4	33.9	9.43	39.49	8.9	35.8
5000	38. 71	7.4	34.9	10.16	39. 51	8.9	36.6
5100	38. 51	7. 1	34.5	10.98	39.41	8. 7	36.8
5200	38. 53	7. 1	36. 3	11.54	39. 51	8.9	38. 7
5300	38. 59	7.2	37.9	11.92	39.61	9.2	40.6
5400	38. 37	6.9	37.2	12. 15	39. 51	8.9	40.5
5500	38.49	7. 1	38.9	11.64	39.67	9.3	42.2
5600	38. 26	6. 7	37.8	11.62	39. 53	9.0	41.1
5700	38. 1	6.5	36. 7	10.59	39.41	8. 7	40.2
5800	38. 01	6. 3	36.0	10.12	39. 39	8. 7	39.9
5900	37.9	6. 2	34.8	10.05	39. 35	8.6	38.9
6000	37.8	6.0	33.2	9. 12	39. 18	8.3	36. 7
6100	37.86	6. 1	33.5	8. 42	39. 28	8. 5	37. 3
6200	37.8	6.0	31.9	8.04	39. 12	8. 2	35. 3

### Features

- High Efficiency and Linear Gain Operations
- Integrated ESD Protection
- Excellent thermal stability, low HCl drift
- Large Positive and Negative Gate/Source Voltage Range for Improved Class C Operation
- Pb-free, RoHS-compliant

### **Suitable Applications**

- C band power amplifier
- 5G cellular power amplifier within 5-6GHz
- WIFI High power access point

**Table 1. Maximum Ratings** 

Rating	Symbol	Value	Unit
DrainSource Voltage	V <sub>DSS</sub>	+65	Vdc
GateSource Voltage	V <sub>GS</sub>	-10 to +10	Vdc
Operating Voltage	$V_{DD}$	+28	Vdc
Storage Temperature Range	Tstg	-65 to +150	°C
Case Operating Temperature	Tc	+150	°C
Operating Junction Temperature	TJ	+225	°C





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### **Table 2. Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case	Rejc	4.4	°C/W
T <sub>C</sub> = 85°C, T <sub>J</sub> =200°C, DC test	RejC	4.1	-0/00

### **Table 3. ESD Protection Characteristics**

Test Methodology	Class	
Human Body Model (per JESD22A114)	Class 2	

### Table 4. Electrical Characteristics (TA = 25 ℃ unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
DC Characteristics					
Drain-Source Voltage	V <sub>(BR)DSS</sub>		65		V
V <sub>GS</sub> =0, I <sub>DS</sub> =100uA	V (BR)DSS		03		V
Zero Gate Voltage Drain Leakage Current				1	^
$(V_{DS} = 28V, V_{GS} = 0 V)$	I <sub>DSS</sub>			ı	μΑ
GateSource Leakage Current				1	^
$(V_{GS} = 11 \text{ V}, V_{DS} = 0 \text{ V})$	I <sub>GSS</sub>			ı	μΑ
Gate Threshold Voltage	V <sub>GS</sub> (th)		2		V
$(V_{DS} = 28V, I_D = 600 \mu A)$	V GS(U1)		2		V
Gate Quiescent Voltage	$V_{GS(Q)}$		2.7		V
(V <sub>DD</sub> = 28V, I <sub>D</sub> = 60mA, Measured in Functional Test)	V GS(Q)		2.1		V

Load Mismatch (In Innogration Test Fixture, 50 ohm system):  $V_{DD} = 28Vdc$ ,  $I_{DQ} = 60mA$ , f = 5000 MHz

VSWR 10:1 at 12W pulse CW Output Power No Device Degradation

Figure 1:Pin Definition(Top View)



Pin No.	Symbol	Description
8,9,10,11	Vgs/RF In	Vgs and RF input
32,33,34,35	Vds/RF out	Vds and RF output
2,5,7,12,13,18,20,23,25,30,31,36	GND	DC/RF Ground
Others	NC	No connection
Package Base	GND	DC/RF Ground.



# Reference Circuit of Test Fixture Assembly Diagram 4900-6200MHz RO4350B 20mils

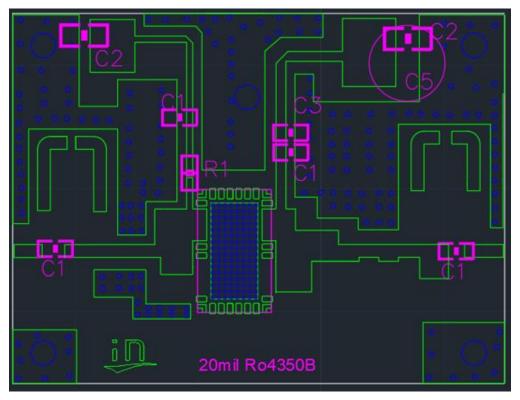


Figure 2. Test Circuit Component Layout

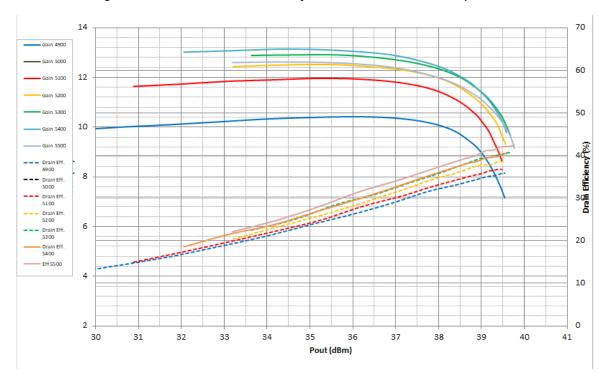
**Table 5. Test Circuit Component Designations and Values** 

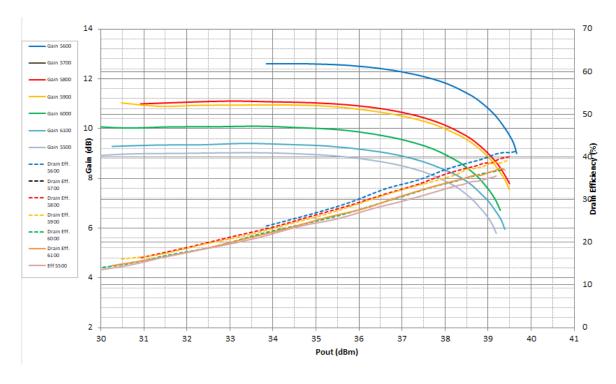
Component	Value	Quantity
C1	3.9pF	4
C2	10uF	2
R1	10 ohm	1
C5	470uF	1
C3	1uF	1



### TYPICAL CHARACTERISTICS

Figure 3. Power Gain and Drain Efficiency as function of Power Out at Idq=6mA

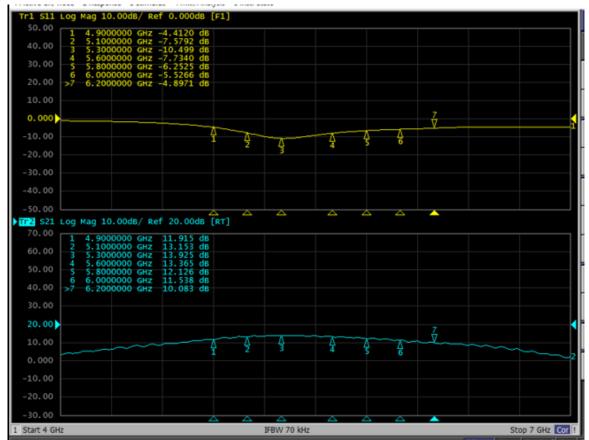






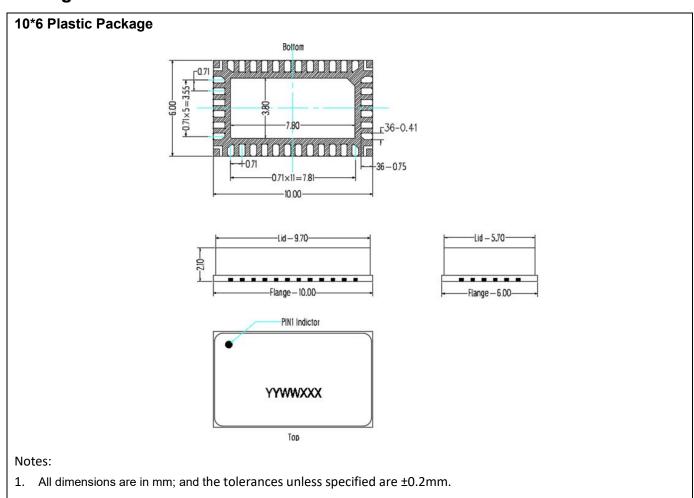
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### Figure 4.Network analyzer output S11/S21



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### **Package Dimensions**



### **Revision history**

Table 7. Document revision history

Date	Revision	Datasheet Status
2022/8/15	Rev 1.0	Preliminary Datasheet
2022/12/9	Rev 1.1	Update on Pin Definition
2024/12/5	Rev 1.2	Use 5.1-5.9G as carrier application
2025/7/18	Rev 1.3	Change the carrier application to 4.9-6.2G

### Application data based on ZXY-22-32/25-10

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